Application/Control No. Issue Classification 10802151 Examiner IAN JEN Applicant(s)/Patent Under Reexamination KIM ET AL. Art Unit 3664

ORIGINAL							INTERNATIONAL CLASSIFICATION									
CLASS SUBCLASS						CLAIMED						NON-CLAIMED				
701 100				G	0	6	F	17 / 00 (2006.01.01)	G	0	6	F	7 / 00 (2006.01.01)			
CROSS REFERENCE(S)											G	0	1	М	17 / 00 (2006.01.01)	
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⊠	Claims renumbered in the same order as presented by applicant								CP	A [] T.D.	☐ R.1.47			
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/IAN JEN/ Examiner.Art Unit 3664	10/30/2008	Total Claims Allowed:				
	(-)	40				
(Assistant Examiner)	(Date)	1				
/KHOI TRAN/ Supervisory Patent Examiner.Art Unit 3664	11/09/2008	O.G. Print Claim(s)	O.G. Print Figure			
(Primary Examiner)	(Date)	1	1			